



# DIM1500ESM33-ML000

Replaces DS6280-1

Single Switch IGBT Module

DS6280-2 February 2019 (LN37353)

# FEATURES

- Low V<sub>CE(sat)</sub> Device
- 10µs Short Circuit Withstand
- High Thermal Cycling Capability
- Soft Punch Through Silicon
- High Current Density Enhanced DMOS SPT
- Isolated AISiC Base With AIN Substrates

# **APPLICATIONS**

- High Reliability Inverters
- Motor Controllers
- Traction Drives
- Choppers

The Powerline range of high power modules includes half bridge, chopper, dual, single and bi-directional switch configurations covering voltages from 1200V to 6500V and currents up to 2400A.

The DIM1500ESM33-ML000 is a single switch 3300V, n-channel enhancement mode, insulated gate bipolar transistor (IGBT) module. The IGBT has a wide reverse bias safe operating area (RBSOA) plus 10µs short circuit withstand. This device is optimised for traction drives and other applications requiring high thermal cycling capability.

The module incorporates an electrically isolated base plate and low inductance construction enabling circuit designers to optimise circuit layouts and utilise grounded heat sinks for safety.

### **ORDERING INFORMATION**

Order As:

# DIM1500ESM33-ML000

Note: When ordering, please use the complete part number

# **KEY PARAMETERS**

V <sub>CES</sub>		3300V
V <sub>CE(sat)</sub>	* (typ)	2.2V
l <sub>c</sub> `	(max)	1500A
I <sub>C(PK)</sub>	(max)	3000A

\* Measured at the auxiliary terminals

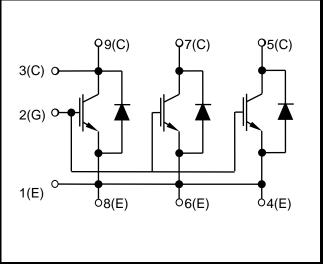
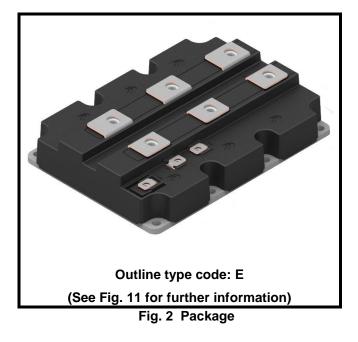


Fig. 1 Circuit configuration



Caution: This device is sensitive to electrostatic discharge. Users should follow ESD handling procedures

### **ABSOLUTE MAXIMUM RATINGS**

Stresses above those listed under 'Absolute Maximum Ratings' may cause permanent damage to the device. In extreme conditions, as with all semiconductors, this may include potentially hazardous rupture of the package. Appropriate safety precautions should always be followed. Exposure to Absolute Maximum Ratings may affect device reliability.

#### T<sub>case</sub> = 25°C unless stated otherwise

Symbol	Parameter	Test Conditions	Max.	Units
V <sub>CES</sub>	Collector-emitter voltage	$V_{GE} = 0V$	3300	V
$V_{\text{GES}}$	Gate-emitter voltage		±20	V
Ι <sub>C</sub>	Continuous collector current	T <sub>case</sub> = 120°C	1500	А
I <sub>C(PK)</sub>	Peak collector current	1ms, T <sub>case</sub> = 138°C	3000	А
P <sub>max</sub>	Max. transistor power dissipation	$T_{case} = 25^{\circ}C, T_j = 150^{\circ}C$	17.9	kW
l <sup>2</sup> t	Diode I <sup>2</sup> t value	$V_R = 0, t_p = 10ms, T_j = 150^{\circ}C$	720	kA <sup>2</sup> s
V <sub>isol</sub>	Isolation voltage – per module	Commoned terminals to base plate. AC RMS, 1 min, 50Hz	6000	V
Q <sub>PD</sub>	Partial discharge – per module	IEC1287, $V_1 = 3500V$ , $V_2 = 2600V$ , 50Hz RMS	10	рС

#### THERMAL AND MECHANICAL RATINGS

Internal insulation material:	AIN
Baseplate material:	AlSiC
Creepage distance:	33mm
Clearance:	20mm
CTI (Comparative Tracking Index):	>600

Symbol	Parameter	Test Conditions	Min	Тур.	Max	Units
R <sub>th(j-c)</sub>	Thermal resistance – transistor	Continuous dissipation - junction to case	-	-	7	°C/kW
R <sub>th(j-c)</sub>	Thermal resistance – diode	Continuous dissipation - junction to case	-	-	12	°C/kW
R <sub>th(c-h)</sub>	Thermal resistance – case to heatsink (per module)	Mounting torque 5Nm (with mounting grease)	-	-	6	°C/kW
T <sub>j</sub> J	Junction temperature	Transistor	-	-	150	°C
		Diode	-	-	150	°C
T <sub>stg</sub>	Storage temperature range	-	-40	-	125	°C
		Mounting – M6	-	-	5	Nm
	Screw torque	Electrical connections – M4	-	-	2	Nm
		Electrical connections – M8	-	-	10	Nm

# **ELECTRICAL CHARACTERISTICS**

#### T<sub>case</sub> = 25°C unless stated otherwise.

Symbol	Parameter	Test Conditions	Min	Тур	Мах	Units
		$V_{GE} = 0V, V_{CE} = V_{CES}$			5	mA
I <sub>CES</sub>	Collector cut-off current	$V_{GE} = 0V, V_{CE} = V_{CES}, T_{case} = 125^{\circ}C$			90	mA
		$V_{GE} = 0V, V_{CE} = V_{CES}, T_{case} = 150^{\circ}C$			150	mA
I <sub>GES</sub>	Gate leakage current	$V_{GE} = \pm 20V, V_{CE} = 0V$			1	μA
V <sub>GE(TH)</sub>	Gate threshold voltage	$I_{C}$ = 120mA, $V_{GE}$ = $V_{CE}$		5.7		V
		V <sub>GE</sub> = 15V, I <sub>C</sub> = 1500A		2.2		V
$V_{\text{CE(sat)}}^{\dagger}$	Collector-emitter saturation voltage	V <sub>GE</sub> = 15V, I <sub>C</sub> = 1500A, T <sub>j</sub> = 125°C		2.6		V
		V <sub>GE</sub> = 15V, I <sub>C</sub> = 1500A, T <sub>j</sub> = 150°C		2.8		V
I <sub>F</sub>	Diode forward current	DC		1500		А
I <sub>FM</sub>	Diode maximum forward current	t <sub>p</sub> = 1ms		3000		Α
	Diode forward voltage	I <sub>F</sub> = 1500A		1.9		V
$V_{F}^{\dagger}$		I <sub>F</sub> = 1500A, T <sub>j</sub> = 125°C		1.9		V
		I <sub>F</sub> = 1500A, T <sub>j</sub> = 150°C		1.9		V
C <sub>ies</sub>	Input capacitance	$V_{CE}$ = 25V, $V_{GE}$ = 0V, f = 1MHz		TBD		nF
Qg	Gate charge	±15V Including external C <sub>ge</sub>		TBD		μC
C <sub>res</sub>	Reverse transfer capacitance	$V_{CE}$ = 25V, $V_{GE}$ = 0V, f = 1MHz		TBD		nF
L <sub>M</sub>	Module inductance			6		nH
R <sub>INT</sub>	Internal transistor resistance			70		μΩ
SC <sub>Data</sub>	Short circuit current, I <sub>sc</sub>	$T_{j} = 150^{\circ}C, V_{CC} = 2500V$ $t_{p} \le 10\mu s, V_{GE} \le 15V$ $V_{CE (max)} = V_{CES} - L^{*} x dI/dt$ IEC 60747-9		5500		A

Note: <sup>†</sup> Measured at the auxiliary terminals <sup>\*</sup> L is the circuit inductance +  $L_M$ 

# **ELECTRICAL CHARACTERISTICS**

#### T<sub>case</sub> = 25°C unless stated otherwise

Symbol	Parameter	Test Conditions	Min	Тур.	Мах	Units
t <sub>d(off)</sub>	Turn-off delay time	I <sub>C</sub> = 1500A		2400		ns
t <sub>f</sub>	Fall time	$V_{GE} = \pm 15V$		660		ns
E <sub>OFF</sub>	Turn-off energy loss	$V_{CE} = 1800V$		3400		mJ
t <sub>d(on)</sub>	Turn-on delay time	$R_{g(ON)} = 1.8\Omega$ $R_{g(OFF)} = 1.8\Omega$		700		ns
t <sub>r</sub>	Rise time	$C_{GE} = 330$ nF		430		ns
E <sub>ON</sub>	Turn-on energy loss	L <sub>s</sub> ~ 150nH		2850		mJ
Q <sub>rr</sub>	Diode reverse recovery charge	I <sub>F</sub> = 1500A		1350		μC
l <sub>rr</sub>	Diode reverse recovery current	$V_{CE} = 1800V$		1400		А
E <sub>rec</sub>	Diode reverse recovery energy	$dI_F/dt = 4000A/\mu s$		1250		mJ

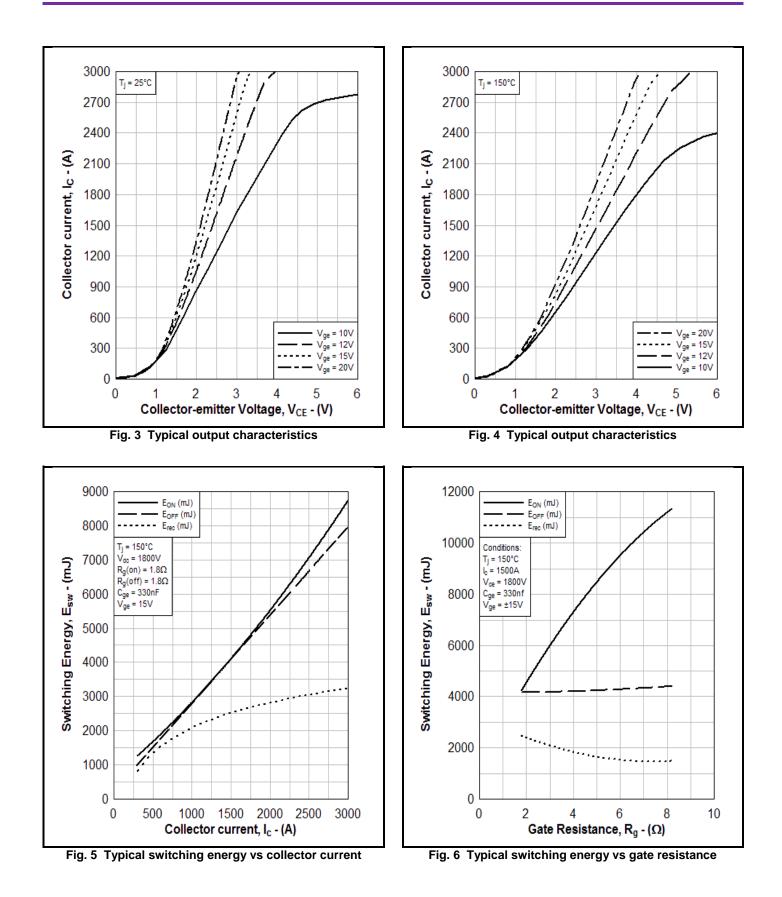
#### T<sub>case</sub> = 125°C unless stated otherwise

Symbol	Parameter	Test Conditions	Min	Тур.	Мах	Units
t <sub>d(off)</sub>	Turn-off delay time	I <sub>C</sub> = 1500A		2430		ns
t <sub>f</sub>	Fall time	$V_{GE} = \pm 15V$		640		ns
E <sub>OFF</sub>	Turn-off energy loss	$V_{CE} = 1800V$		3750		mJ
t <sub>d(on)</sub>	Turn-on delay time	$R_{g(ON)} = 1.8\Omega$ $R_{g(OFF)} = 1.8\Omega$		750		ns
t <sub>r</sub>	Rise time	$C_{GE} = 330$ nF		470		ns
E <sub>ON</sub>	Turn-on energy loss	L <sub>s</sub> ~ 150nH		3600		mJ
Q <sub>rr</sub>	Diode reverse recovery charge	I <sub>F</sub> = 1500A		2160		μC
l <sub>rr</sub>	Diode reverse recovery current	V <sub>CE</sub> = 1800V		1790		А
E <sub>rec</sub>	Diode reverse recovery energy	dl <sub>F</sub> /dt = 4000A/µs		2200		mJ

#### T<sub>case</sub> = 150°C unless stated otherwise

Symbol	Parameter	Test Conditions	Min	Тур.	Мах	Units
t <sub>d(off)</sub>	Turn-off delay time	I <sub>C</sub> = 1500A		2450		ns
t <sub>f</sub>	Fall time	$V_{GE} = \pm 15V$		640		ns
E <sub>OFF</sub>	Turn-off energy loss	$V_{CE} = 1800V$		4100		mJ
t <sub>d(on)</sub>	Turn-on delay time	$R_{g(ON)} = 1.8\Omega$ $R_{g(OFF)} = 1.8\Omega$		700		ns
t <sub>r</sub>	Rise time	$C_{GE} = 330 nF$		470		ns
E <sub>ON</sub>	Turn-on energy loss	L <sub>s</sub> ~ 150nH		4100		mJ
Q <sub>rr</sub>	Diode reverse recovery charge	I <sub>F</sub> = 1500A		2450		μC
١ <sub>rr</sub>	Diode reverse recovery current	V <sub>CE</sub> = 1800V		1850		Α
E <sub>rec</sub>	Diode reverse recovery energy	dI <sub>F</sub> /dt = 4000A/µs		2500		mJ

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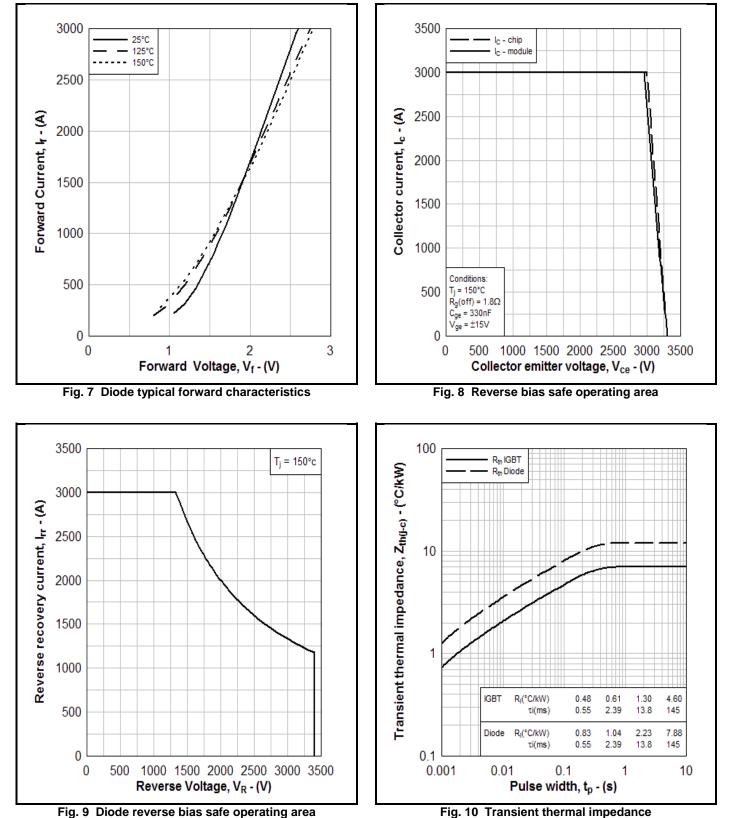


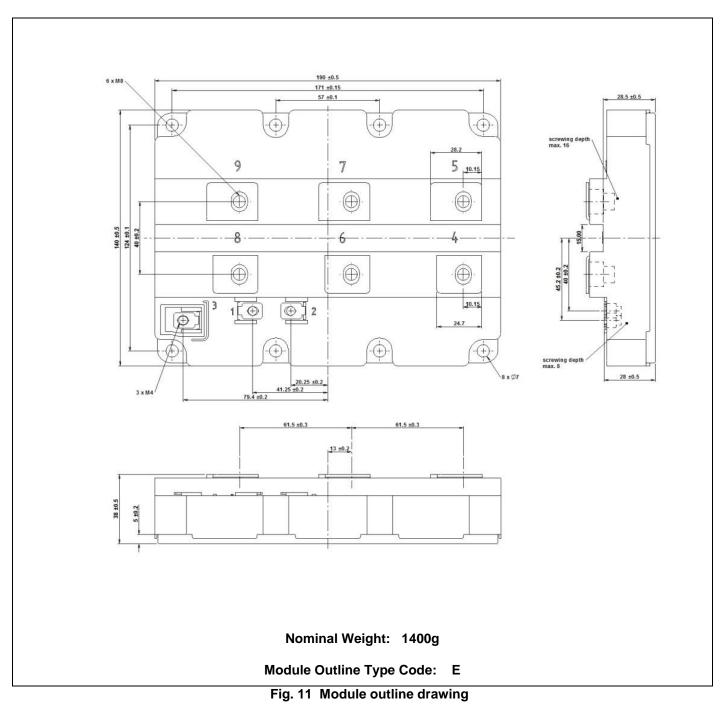
Fig. 10 Transient thermal impedance

@ #YNCX



#### PACKAGE DETAILS

For further package information, please visit our website or contact Customer Services. All dimensions in mm, unless stated otherwise. **DO NOT SCALE.** 



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